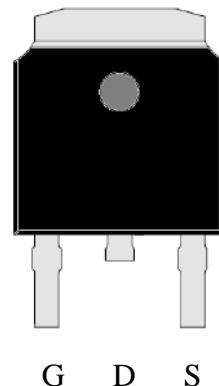


N-Channel Enhancement Mode Power MOSFET

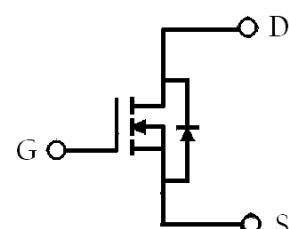
Features:

- Low On Resistance
- Simple Drive Requirement
- Low Gate Charge
- Fast Switching Characteristic
- Pb-free lead plating and halogen-free package

TO-252(DPAK)



BV_{DSS}	60V
I_D@V_{GS}=10V, T_C=25°C	50A
R_{D(S)}(ON)@V_{GS}=10V, I_D=20A	7 mΩ(typ)



G : Gate D : Drain S : Source

Ordering Information

Device	Package	Shipping
KJE09N06	TO-252 (Pb-free lead plating and halogen-free package)	2500 pcs / tape& reel

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage (Note 1)	V _{DS}	60	V
Gate-Source Voltage	V _{GS}	± 20	
Continuous Drain Current @ $T_C=25^\circ\text{C}$, $V_{GS}=10\text{V}$ (silicon limit) (Note 1)	ID	70	A
Continuous Drain Current @ $T_C=100^\circ\text{C}$, $V_{GS}=10\text{V}$ (silicon limit) (Note 1)		50	
Continuous Drain Current @ $T_C=25^\circ\text{C}$, $V_{GS}=10\text{V}$ (package limit) (Note 1)		50	
Continuous Drain Current @ $T_A=25^\circ\text{C}$, $V_{GS}=10\text{V}$ (Note 2)		13	
Continuous Drain Current @ $T_A=70^\circ\text{C}$, $V_{GS}=10\text{V}$ (Note 2)	IDSM	10	A
Pulsed Drain Current @ $V_{GS}=10\text{V}$ (Note 3)	IDM	180	
Avalanche Current (Note 3)	I _{AS}	45	
Single Pulse Avalanche Energy @ $L=0.1\text{mH}$, $ID=45\text{A}$, $V_{DD}=25\text{V}$ (Note 2)	E _{AS}	101	mJ
Repetitive Avalanche Energy (Note 3)	E _{AR}	10	
Power Dissipation	P _D	75	W
		37.5	
	P _{DSM}	2.5	
		1.6	
Operating Junction and Storage Temperature	T _j , T _{stg}	-55~+175	°C

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R _{θJC}	2	°C/W
Thermal Resistance, Junction-to-ambient, max (Note 2)	R _{θJA}	50	
Thermal Resistance, Junction-to-ambient, max (Note 4)		110	

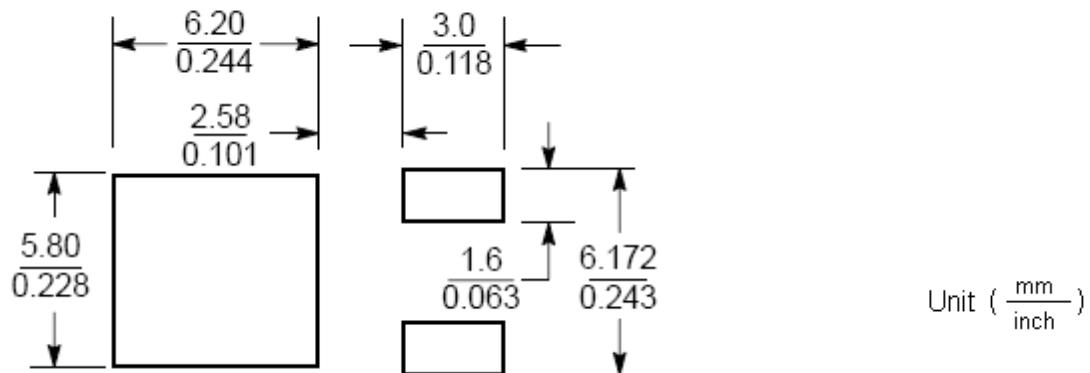
- Note : 1.The power dissipation P_D is based on $T_{J(MAX)}=175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
2. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with $T_A=25^\circ\text{C}$. The power dissipation P_{DSM} is based on R_{θJA} and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
3. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=175^\circ\text{C}$. Ratings are based on low frequency and low duty cycles to keep initial T_j=25°C.
4. When mounted on the minimum pad size recommended (PCB mount), t≤10s.

Characteristics (T_j=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	60	-	-	V	V _{GS} =0V, I _D =250μA
ΔBV _{DSS} /ΔT _j	-	0.06	-	V/°C	Reference to 25°C, I _D =250μA
V _{GS(th)}	2.0	-	4.0	V	V _{DS} = V _{GS} , I _D =250μA
*G _{FS}	-	29	-	S	V _{DS} =5V, I _D =20A
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =48V, V _{GS} =0V
	-	-	10		V _{DS} =48V, V _{GS} =0V, T _j =125°C
*R _{DSD(ON)}	-	7	9.5	mΩ	V _{GS} =10V, I _D =20A
Dynamic					
*Q _g	-	32	-	nC	V _{DD} =30V, I _D =20A, V _{GS} =10V
*Q _{gs}	-	7.5	-		
*Q _{gd}	-	9.7	-		
*t _{d(ON)}	-	16	-		
*tr	-	22.8	-	ns	V _{DD} =30V, I _D =20A, V _{GS} =10V, R _G =3Ω
*t _{d(OFF)}	-	39.4	-		
*t _f	-	15	-		
C _{iss}	-	1500	-	pF	V _{GS} =0V, V _{DS} =30V, f=1MHz
C _{oss}	-	272	-		
C _{rss}	-	140	-		
R _g	-	2.2	-		
Source-Drain Diode					
*I _s	-	-	50	A	
*V _{SD}	-	0.69	1	V	I _s =1A, V _{GS} =0V
*trr	-	21	-	ns	V _{GS} =0V, I _F =20A, dI _F /dt=100A/μs
*Q _{rr}	-	18.5	-	nC	

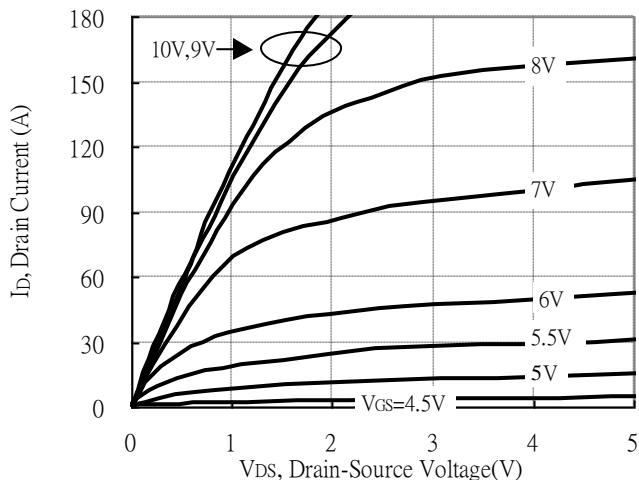
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Recommended soldering footprint

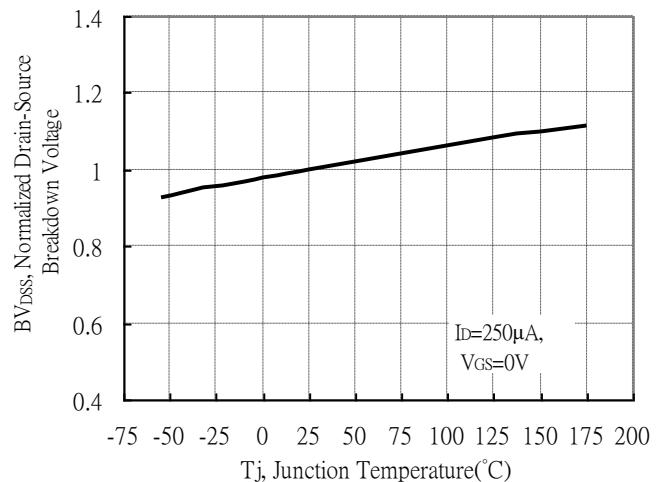


Typical Characteristics

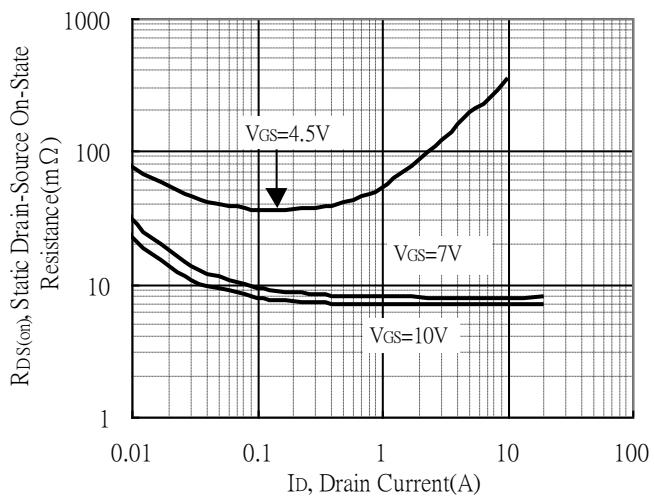
Typical Output Characteristics



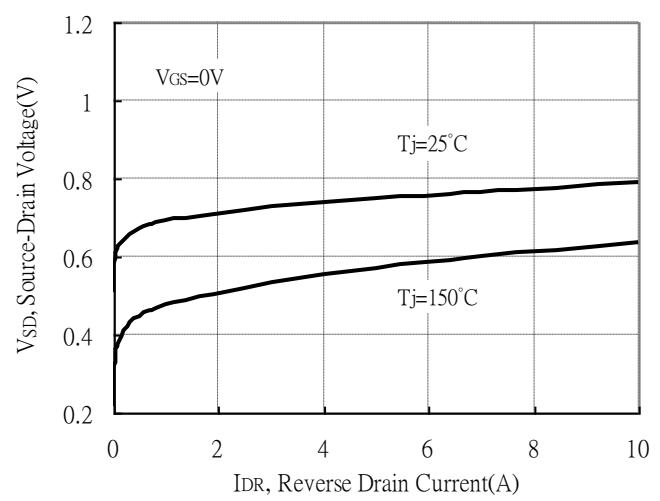
Breakdown Voltage vs Ambient Temperature



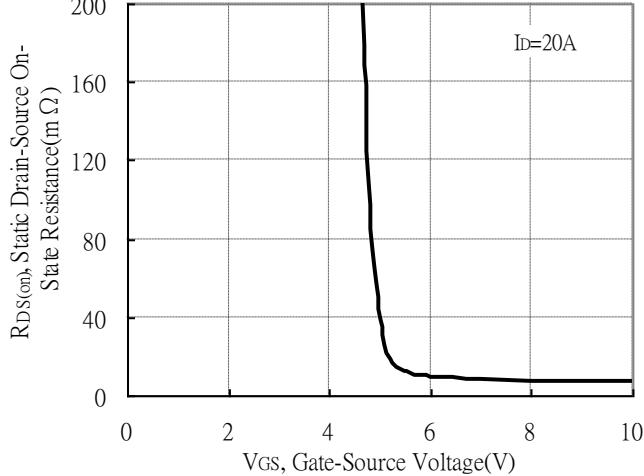
Static Drain-Source On-State resistance vs Drain Current



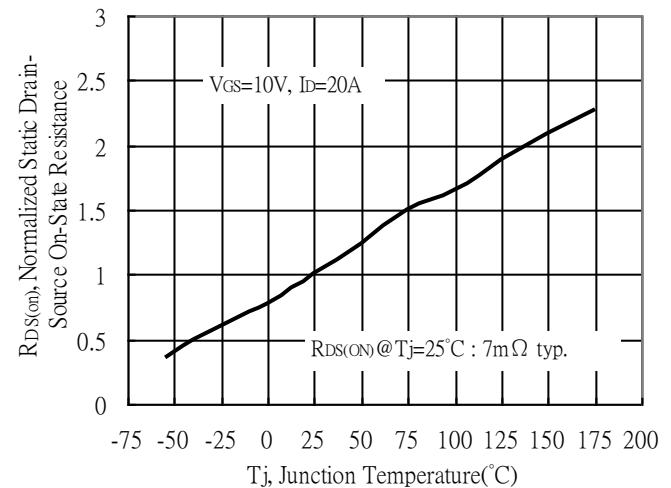
Reverse Drain Current vs Source-Drain Voltage



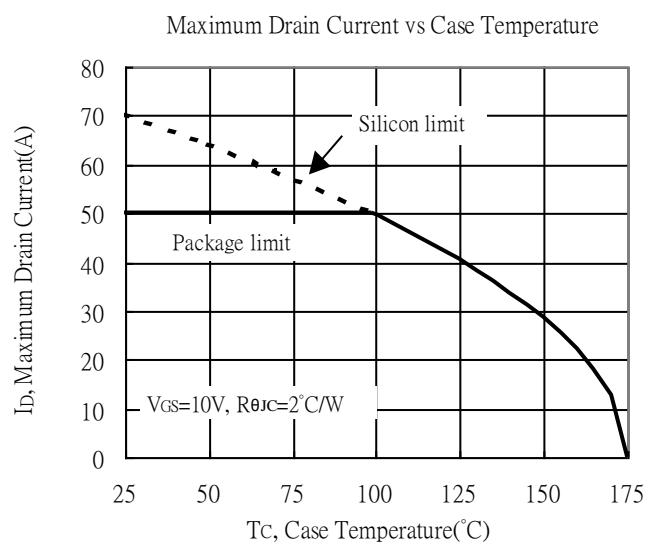
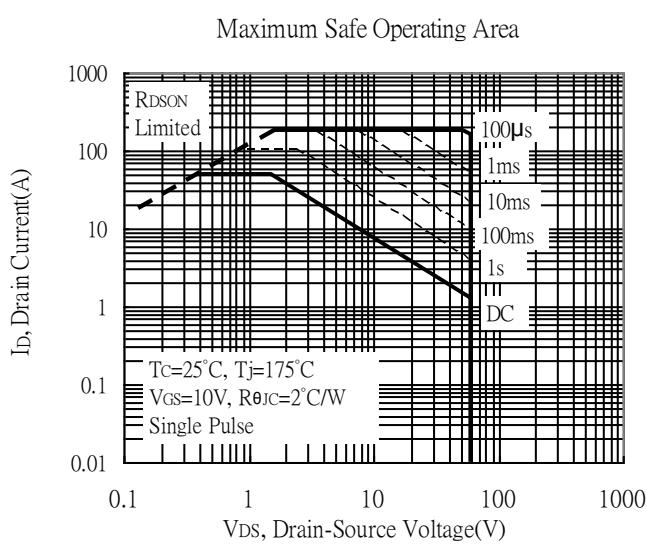
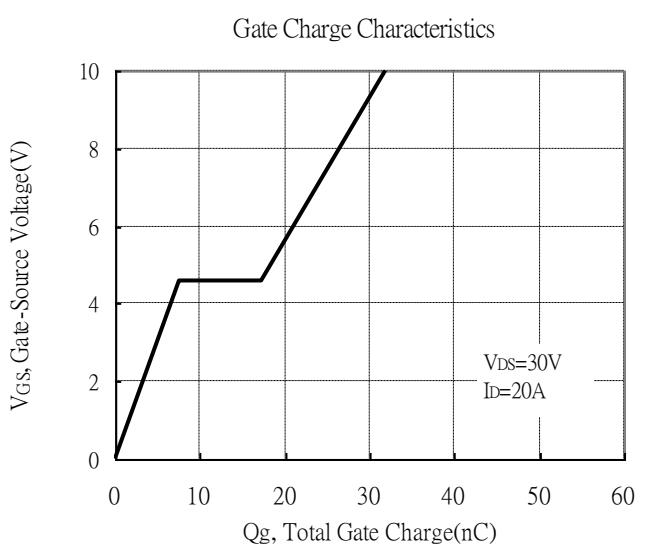
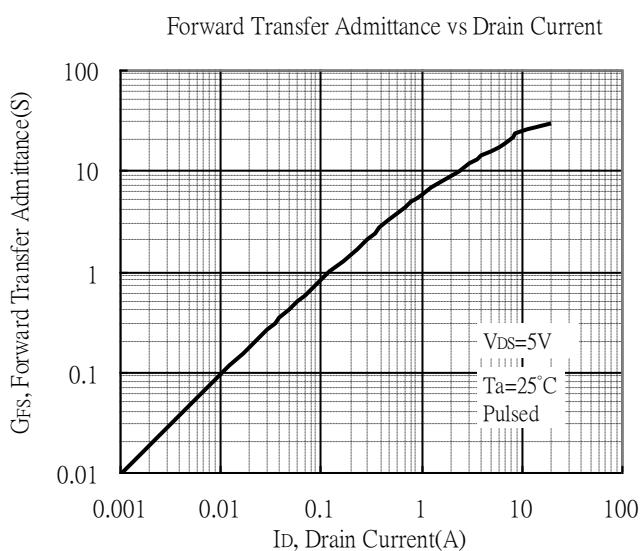
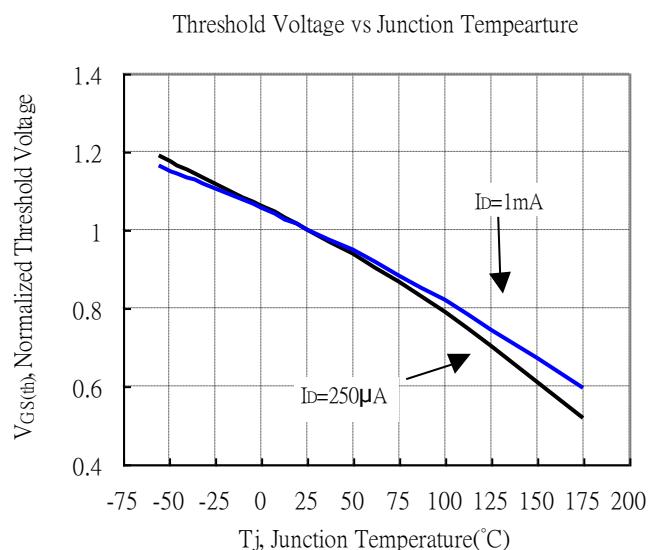
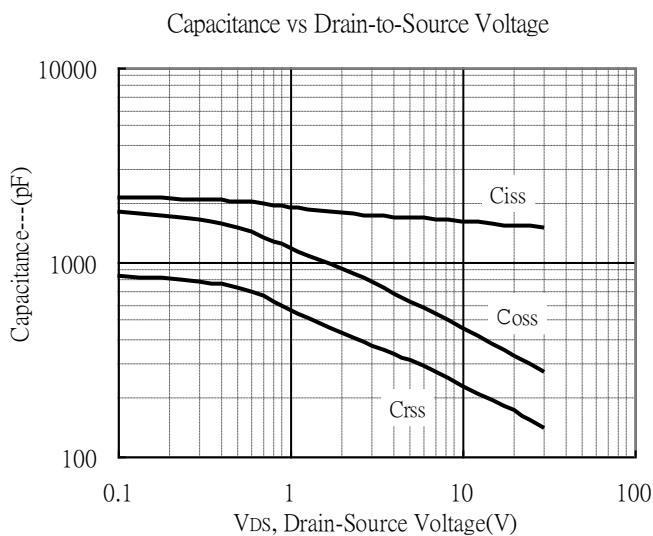
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

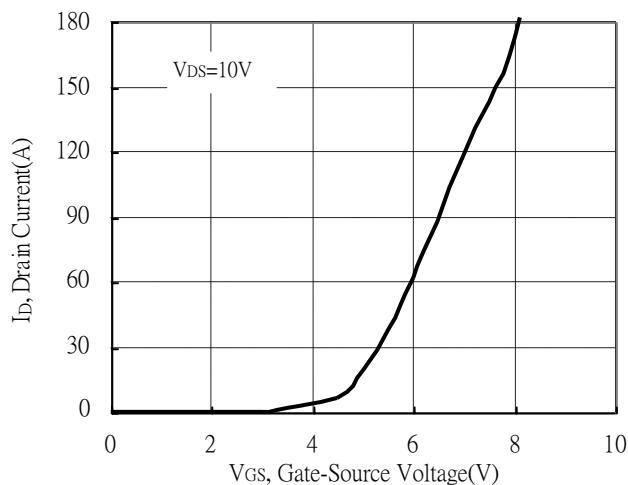


Typical Characteristics(Cont.)

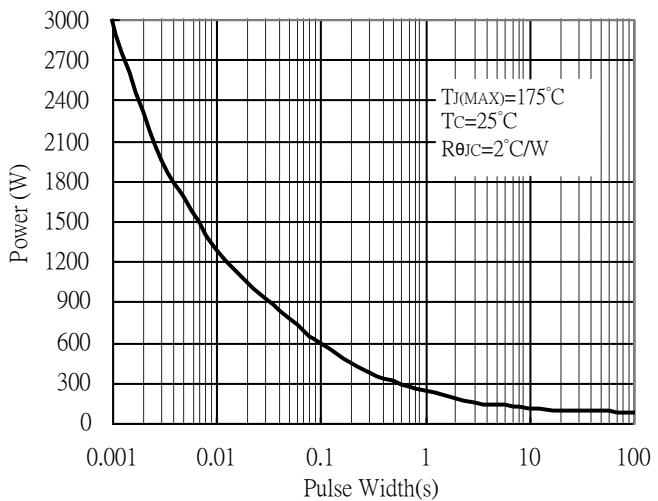


Typical Characteristics(Cont.)

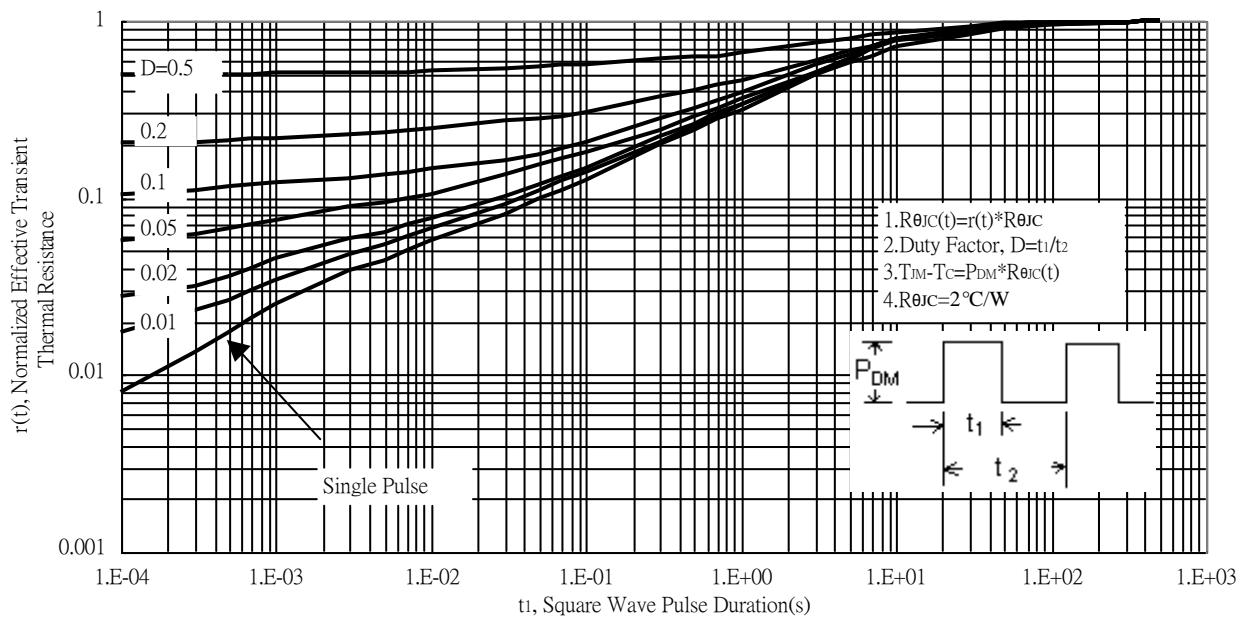
Typical Transfer Characteristics



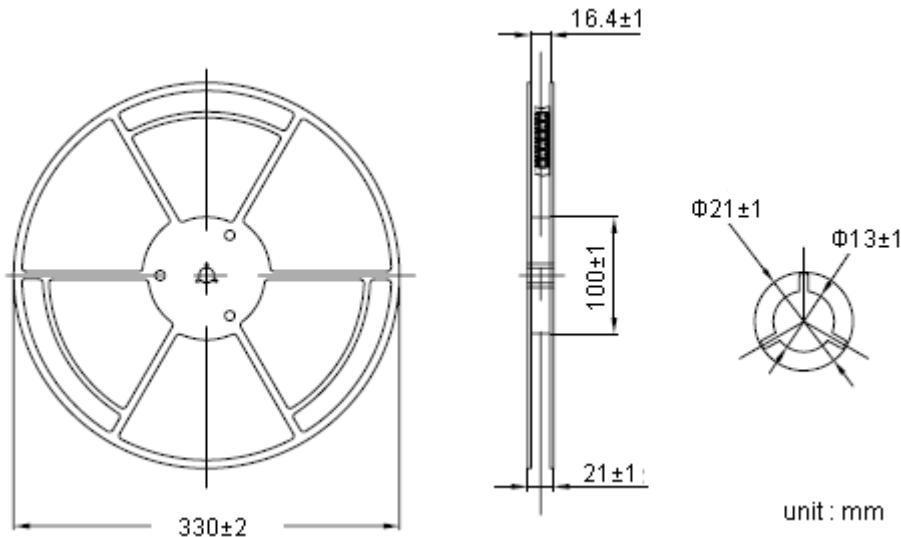
Single Pulse Power Rating, Junction to Case



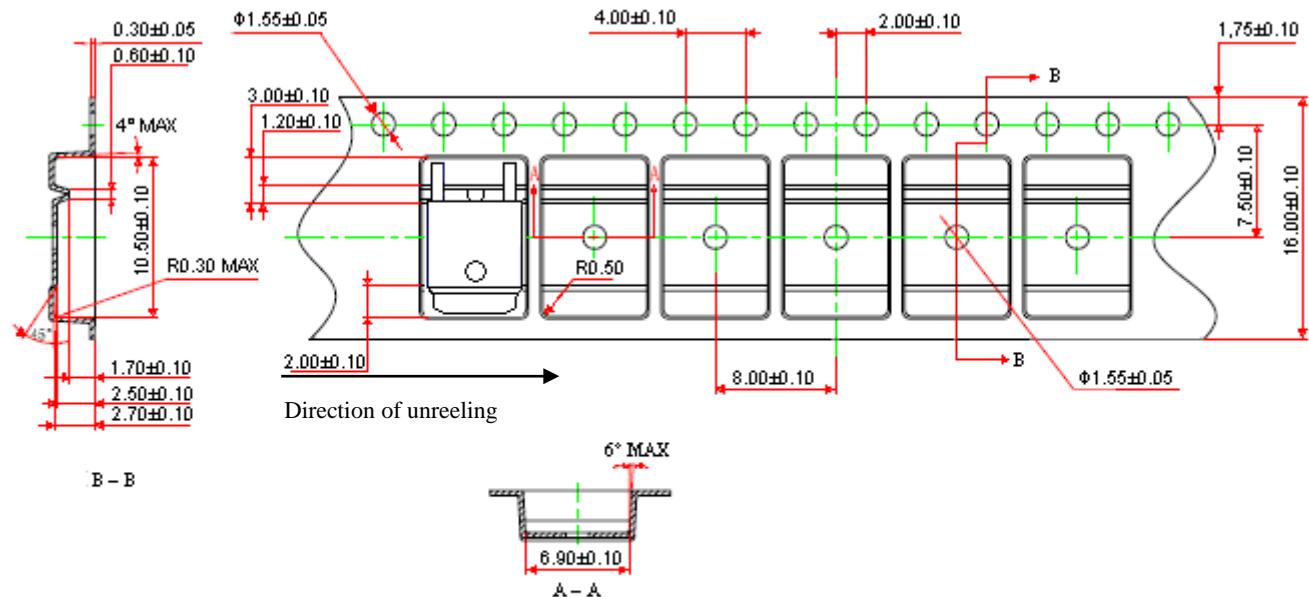
Transient Thermal Response Curves



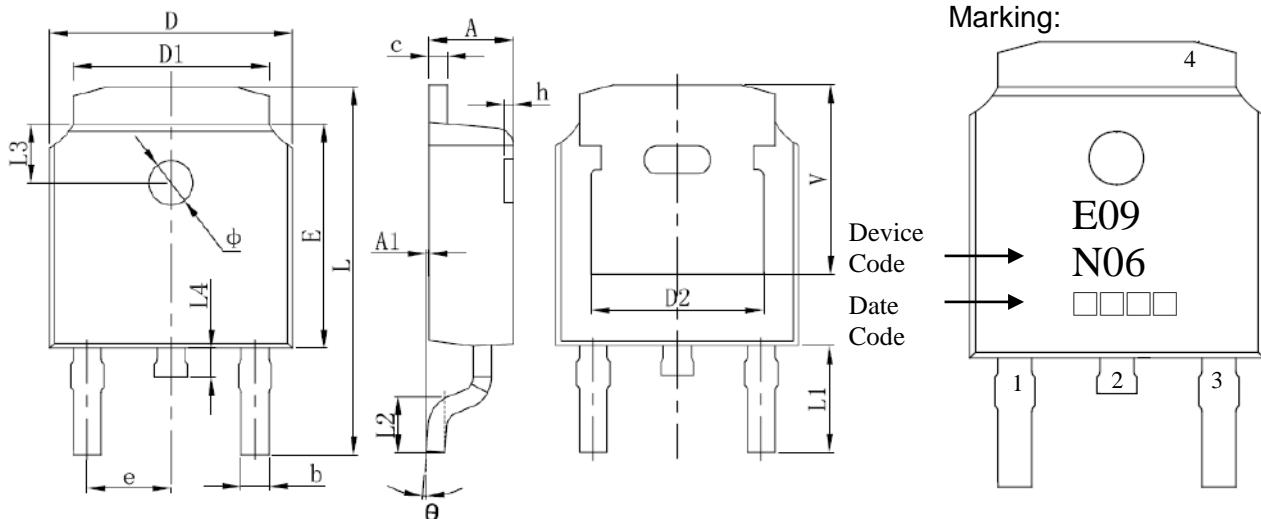
Reel Dimension



Carrier Tape Dimension



TO-252 Dimension



3-Lead TO-252 Plastic Surface Mount Package

Style: Pin 1.Gate 2.Drain 3.Source
4.Drain

Date Code :

First Code : Last digit of Christian Year

Second Code : Month Code : Jan→A, Feb→B, Mar→C, Apr→D, May→E, Jun→F, Jul→G,
Aug→H, Sep→J, Oct→K, Nov→L, Dec→M

Last Two Codes : Production Serial Code, 01~99

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.087	0.094	2.200	2.400	L	0.382	0.406	9.712	10.312
A1	0.000	0.005	0.000	0.127	L1	0.114	REF	2.900	REF
b	0.025	0.030	0.635	0.770	L2	0.055	0.067	1.400	1.700
c	0.018	0.023	0.460	0.580	L3	0.063	REF	1.600	REF
D	0.256	0.264	6.500	6.700	L4	0.024	0.039	0.600	1.000
D1	0.201	0.215	5.100	5.460	Φ	0.043	0.051	1.100	1.300
D2	0.190	REF	4.830	REF	θ	0°	8°	0°	8°
E	0.236	0.244	6.000	6.200	h	0.000	0.012	0.000	0.300
e	0.086	0.094	2.186	2.386	v	0.207	REF	5.250	REF